

Notice of References Cited	Application/Control No. 10/604,747	Applicant(s)/Patent Under Reexamination HERR ET AL.	
	Examiner M. Wilczewski	Art Unit 2822	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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